


<b>Search Notes</b>  	<b>Application/Control No.</b>  10762094	<b>Applicant(s)/Patent Under Reexamination</b>  BATTHISH ET AL.
	<b>Examiner</b>  San Juan, Martin Jeriko P	<b>Art Unit</b>  2109

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE (Del Sole, Joseph).	2/12/2007	MJSJ
EAST Search (see attached).	2/12/2007	MJSJ
Consulted with Art Unit 2132 (Lanier, Benjamin)	2/15/2007	MJSJ
Inventor Search, reviewed related applications (see attached).	2/21/2007	MJSJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner